

<b>Notice of References Cited</b>	Application/Control No. 10/718,810	Applicant(s)/Patent Under Reexamination NAKAGAWA, HAYAMI	
	Examiner Gregory J. Strimbu	Art Unit 3634	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,139,088	10-2000	Okamoto et al.	296/146.6
	B	US-6,640,497	11-2003	Sakaguchi et al.	49/352
	C	US-4,648,208	03-1987	Baldamus et al.	49/502
	D	US-5,090,158	02-1992	Bertolini, Carlo	49/348
	E	US-5,379,553	01-1995	Kimura et al.	49/502
	F	US-5,927,021	07-1999	Kowalski et al.	49/502
	G	US-6,076,882	06-2000	Szerdahelyi et al.	296/146.1
	H	US-6,176,542	01-2001	Gooding et al.	296/146.6
	I	US-2004/0049989	03-2004	Florentin et al.	049/502
	J	US-2003/0140566	07-2003	Sommer et al.	49/502
	K	US-2002/0066232	06-2002	Tatsumi et al.	49/502
	L	US-2002/0007598	01-2002	Nishikawa et al.	49/502
	M	US-6,732,474	05-2004	Eck et al.	49/502

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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